

Notice of References Cited	Application/Control No.	Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner Hanh Nguyen	Art Unit 2662	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5159595	10-1992	Flanagan et al.	370/224
	B	US-5187706	02-1993	Frankel et al.	370/217
	C	US-6002689	12-1999	Christie et al.	370/401
	D	US-6208657	03-2001	Dendi et al.	370/401
	E	US-6643297 B1	11-2003	Sproat et al.	370/498
	F	US-5809021	09-1998	Diaz et al.	370/364
	G	US-6470018 B1	10-2002	Wiley et al.	370/396
	H	US-6041055	03-2000	CHopping	370/391
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.